IS42S32800B



July 2006

2M Words x 32 Bits x 4 Banks (256-MBIT) SYNCHRONOUS DYNAMIC RAM

FEATURES

- · Concurrent auto precharge
- · Clock rate:166/143 MHz
- · Fully synchronous operation
- · Internal pipelined architecture
- · Four internal banks (2M x 32bit x 4bank)
- · Programmable Mode
 - -CAS#Latency:2 or 3
 - -Burst Length:1,2,4,8,or full page
 - -Burst Type:interleaved or linear burst
 - -Burst-Read-Single-Write
- Burst stop function
- \cdot Individual byte controlled by DQM0-3
- · Auto Refresh and Self Refresh
- \cdot 4096 refresh cycles/64ms (15.6 $\mu s/row)$
- \cdot Single +3.3V ±0.3V power supply
- · Interface:LVTTL
- · Package: 86 Pin TSOP-2,0.50mm Pin Pitch
- 8x13mm, 90 Ball BGA, Ball pitch 0.8mm
- \cdot Pb-free package is available.

DESCRIPTION

The **ISSI** IS42S32800B is a high-speed CMOS configured as a quad 2M x 32 DRAM with a synchronous interface (all signals are registered on the positive edge of the clock signal,CLK).

Each of the 2M x 32 bit banks is organized as 4096 rows by 512 columns by 32 bits.Read and write accesses start at a selected locations in a programmed sequence. Accesses begin with the registration of a BankActive command which is then followed by a Read or Write command

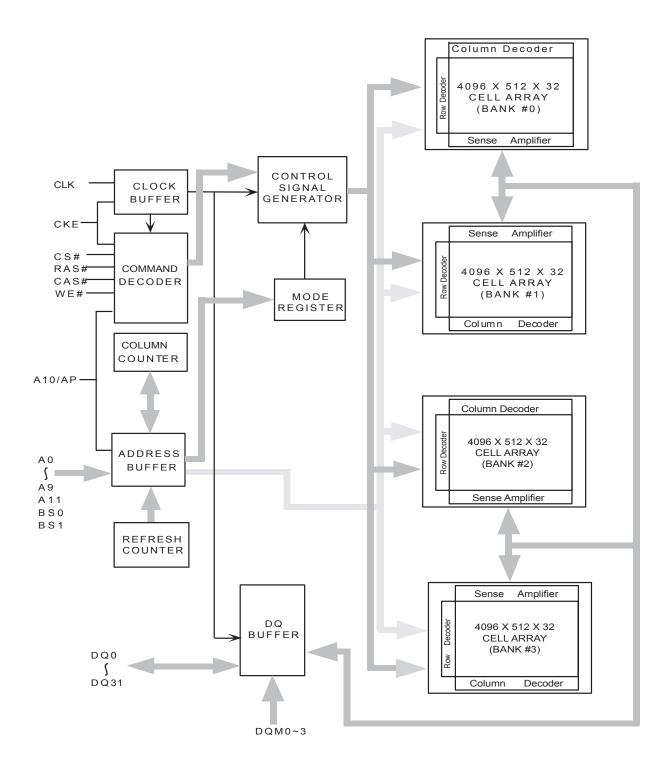
The **ISSI** IS42S32800B provides for programmable Read or Write burst lengths of 1,2,4,8,or full page, with a burst termination operation. An auto precharge function may be enable to provide a self-timed row precharge that is initiated at the end of the burst sequence.The refresh functions, either Auto or Self Refresh are easy to use.

By having a programmable mode register, the system can choose the most suitable modes to maximize its performance.

These devices are well suited for applications requiring high memory bandwidth.



FUNCTIONAL BLOCK DIAGRAM



PIN DESCRIPTIONS

Table 1.Pin Details of IS42S32800B

Symbol	Туре	Description
CLK	Input	Clock:CLK is driven by the system clock.All SDRAM input signals are sampled on the positive edge
		of CLK.CLK also increments the internal burst counter and controls the output registers.
CKE	Input	Clock Enable: CKE activates (HIGH) and deactivates (LOW) the CLK signal. If CKE goes low syn-
	mpat	chronously with clock(set-up and hold time same as other inputs),the internal clock is suspended
		from the next clock cycle and the state of output and burst address is frozen as long as the CKE
		remains low. When all banks are in the idle state, deactivating the clock controls the entry to the
		Power Down and Self Refresh modes.CKE is synchronous except after the device enters Power
		Down and Self Refresh modes, where CKE becomes asynchronous until exiting the same mode.
		The input buffers, including CLK, are disabled during Power Down and Self Refresh modes, providing
		low standby power.
BS0,BS	1 Input	Bank Select: BS0 and BS1 defines to which bank the BankActivate, Read, Write, or BankPrecharge
	-	command is being applied.
A0-A11	Input	Address Inputs: A0-A11 are sampled during the BankActivate command (row address A0-A11) and
	•	Read/Write command (column address A0-A7 with A10 defining Auto Precharge) to select one
		location in the respective bank. During a Precharge command, A10 is sampled to determine if all
		banks are to be precharged (A10 =HIGH).
		banks are to be precharged (A to -ritori).
		The address inputs also provide the op-code during a Mode Register Set .
CS#	Input	Chip Select:CS#enables (sampled LOW)and disables (sampled HIGH)the command decoder.All
001	mpat	commands are masked when CS#is sampled HIGH.CS#provides for external bank selection on
		systems with multiple banks. It is considered part of the command code.
		systems with multiple banks. It is considered part of the command code.
RAS#	Input	Row Address Strobe: The RAS#signal defines the operation commands in conjunction with the
		CAS#and WE#signals and is latched at the positive edges of CLK.When RAS# and CS#are as-
		serted "LOW" and CAS# is asserted "HIGH," either the BankActivate command or the Precharge
		command is selected by the WE#signal.When the WE#is asserted "HIGH,"the BankActivate com-
		mand is selected and the bank designated by BS is turned on to the active state. When the WE#is
		asserted "LOW,"the Precharge command is selected and the bank designated by BS is switched to
		the idle state after the precharge operation.
CAS#	Input	Column Address Strobe: The CAS#signal defines the operation commands in conjunction with the
		RAS#and WE#signals and is latched at the positive edges of CLK. When RAS#is held "HIGH" and
		CS#is asserted "LOW,"the column access is started by asserting CAS#"LOW."Then, the Read or
		Write command is selected by asserting WE# "LOW" or "HIGH."
WE#	Input	Write Enable: The WE#signal defines the operation commands in conjunction with the RAS#and
•••	mpat	CAS#signals and is latched at the positive edges of CLK.The WE#input is used to select the
		BankActivate or Precharge command and Read or Write command.
DQM0-3	3 Input	Data Input/Output Mask:DQM0-DQM3 are byte specific,nonpersistent I/O buffer controls. The I/O
		buffers are placed in a high-z state when DQM is sampled HIGH.Input data is masked when DQM
		is sampled HIGH during a write cycle.Output data is masked (two-clock latency)when DQM is
		sampled HIGH during a read cycle.DQM3 masks DQ31-DQ24,DQM2 masks DQ23-DQ16,DQM1
		masks DQ15-DQ8,and DQM0 masks DQ7-DQ0.
DQ0-31	Input/C	Dutput Data I/O: The DQ0-31 input and output data are synchronized with the positive edges of

CLK.The I/Os are byte-maskable during Reads and Writes.



PIN CONFIGURATIONS 86 pin TSOP - Type II for x32

		T Vss
	F	
VDDQ		
		1 DQ14
		1 DQ13
VssQ		VDDQ
DQ3		DQ12
DQ4]] DQ11
VDDQ		VssQ
DQ5	10 77]] DQ10
DQ6	11 76	DQ9
VssQ	12 75	UDDQ
DQ7	13 74	DQ8
	14 73	
VDD T	15 72	Vss
	16 71	
		TI NC
A11		
ВАО П		1 A8
BAU []		∏ A7
		☐ A5
A2 [[1 A3
	F	DQM3
		Vss
DQ16 [[DQ31
VssQ 🔲		1 VddQ
DQ17 [[DQ30
DQ18 []] DQ29
	35 52	∐ VssQ
DQ19 [36 51	1 DQ28
DQ20 [37 50]] DQ27
VssQ 🔲	38 49	∏ VddQ
DQ21	39 48	DQ26
DQ22]] DQ25
DQ23		TI DQ24
		TI Vss

PIN DESCRIPTIONS

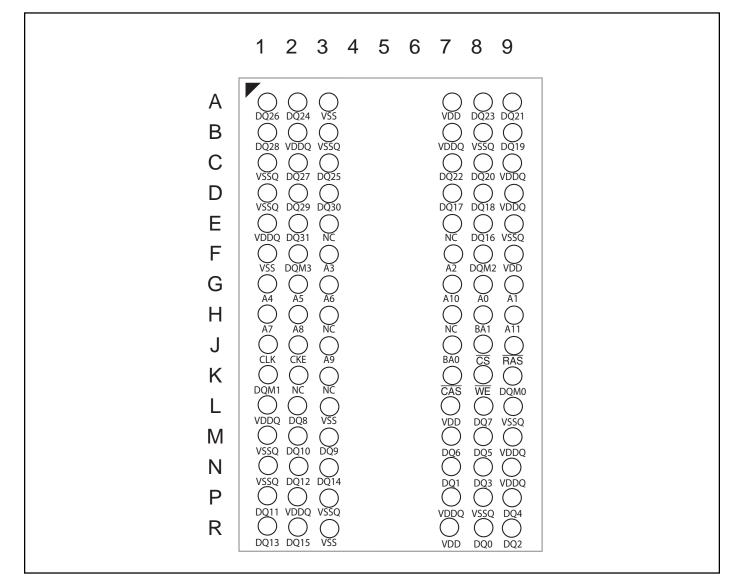
A0-A11	Row Address Input
A0-A8	Column Address Input
BA0, BA1	Bank Select Address
DQ0 to DQ31	Data I/O
CLK	System Clock Input
CKE	Clock Enable
<u>CS</u>	Chip Select
RAS	Row Address Strobe Command
CAS	Column Address Strobe Command

Write Enable
x32 Input/Output Mask
Power
Ground
Power Supply for I/O Pin
Ground for I/O Pin
NoConnection



PIN CONFIGURATION

PACKAGE CODE: B 90 BALL FBGA (Top View) (8.00 mm x 13.00 mm Body, 0.8 mm Ball Pitch)



PIN DESCRIPTIONS

A0-A11	Row Address Input
A0-A8	Column Address Input
BA0, BA1	Bank Select Address
DQ0 to DQ31	Data I/O
CLK	System Clock Input
CKE	Clock Enable
CS	Chip Select
RAS	Row Address Strobe Command
CAS	Column Address Strobe Command

WE	WriteEnable
DQM0-DQM3	x32 Input/Output Mask
Vdd	Power
Vss	Ground
VDDQ	Power Supply for I/O Pin
Vssq	Ground for I/O Pin
NC	NoConnection



Operation Mode

Fully synchronous operations are performed to latch the commands at the positive edges of CLK.Table 2 shows the truth table for the operation commands.

					•		· // //				
Command	State	CKEn-1	CKE	DQM ⁽⁶⁾	BS0,1	A10	A11,A9-0	CS#	RAS#	CAS#	WE#
BankActivate	Idle (3)	Н	Х	Х	V	Row	address	L	L	Н	Н
BankPrecharge	Any	Н	Х	Х	V	L	Х	L	L	Н	L
PrechargeAll	Any	Н	Х	Х	Х	Н	Х	L	L	Н	L
Write	Active (3)	Н	Х	Х	V	L	Column	L	Н	L	L
Write and Auto Precharge	Active (3)	Н	Х	Х	V	Н	address (A0 ~A7)	L	Н	L	L
Read	Active (3)	Н	Х	Х	V	L	Column	L	Н	L	Н
Read and Autoprecharge	Active (3)	Н	Х	Х	V	Н	address (A0 ~A7)	L	Η	L	Н
Mode Register	Set Idle	Н	Х	Х		OP o	code	L	L	L	L
No-Operation	Any	Н	Х	Х	Х	Х	Х	L	Н	Н	Н
Burst Stop	Active ⁽⁴⁾	Н	Х	Х	Х	Х	Х	L	Н	Н	L
Device Deselect	Any	Н	Х	Х	Х	Х	Х	Н	Х	Х	Х
AutoRefresh	Idle	Н	Н	Х	Х	Х	Х	L	L	L	Н
SelfRefresh Entry	Idle	Н	L	Х	Х	Х	Х	L	L	L	Н
SelfRefresh Exit	Idle	L	Н	Х	Х	Х	Х	Н	Х	Х	Х
	(SelfRefresh)							L	Н	Н	Н
Clock Suspend Mode Entry	Active	Н	L	Х	Х	Х	Х	Х	Х	Х	Х
Power Down Mode Entry	Any ⁽⁵⁾	Н	L	Х	Х	Х	Х	Н	Х	Х	Х
								L	Н	Н	Н
Clock Suspend Mode Exit	Active	L	Н	Х	Х	Х	Х	Х	Х	Х	Х
Power Down Mode Exit	Any	L	Н	Х	Х	Х	Х	Н	Х	Х	Х
	(PowerDown)							L	Н	Н	Н
Data Write/Output Enable	Active	Н	Х	L	Х	Х	Х	Х	Х	Х	Х
Data Mask/Output Disable	Active	Н	Х	Н	Х	Х	Х	Х	Х	Х	Х

Table 2.Truth Table (Note (1),(2))

Note:

1. V =Valid,X =Don 't care,L =Logic low,H =Logic high

2. CKEn signal is input level when commands are provided.

CKEn-1 signal is input level one clock cycle before the commands are provided.

3. These are states of bank designated by BS signal.

4. Device state is 1,2,4,8,and full page burst operation.

5. Power Down Mode can not enter in the burst operation.

When this command is asserted in the burst cycle, device state is clock suspend mode.

6. DQM0-3

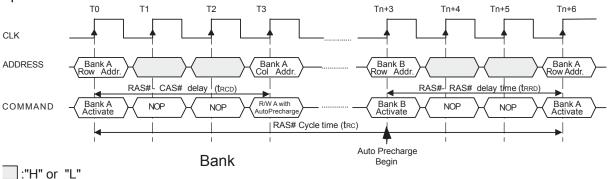


Commands

1 BankActivate

(RAS#="L",CAS#="H",WE#="H",BS =Bank,A0-A11 =Row Address)

The BankActivate command activates the idle bank designated by the BS0,1 (Bank Select) signal.By latching the row address on A0 to A11 at the time of this command, the selected row access is initiated. The read or write operation in the same bank can occur after a time delay of tRCD(min.)from the time of bank activation.A subsequent BankActivate command to a different row in the same bank can only be issued after the previous active row has been precharged (refer to the following figure). The minimum time interval between successive BankActivate commands to the same bank is defined by tRC(min.). The SDRAM has four internal banks on the same chip and shares part of the internal circuitry to reduce chip area; therefore it restricts the back-to-back activation of the four banks.tRRD(min.) specifies the minimum time required between activating different banks. After this command is used, the Write command and the Block Write command perform the no mask write operation.



2 BankPrecharge command

(RAS#="L",CAS#="H",WE#="L",BS =Bank,A10 ="L")

The BankPrecharge command precharges the bank disignated by BS0,1 signal.The

precharged bank is switched from the active state to the idle state. This command can be asserted anytime after tRAS(min.) is satisfied from the BankActivate command in the desired bank. The maximum time any bank can be active is specified by tRAS(max.). Therefore, the precharge function must be performed in any active bank within tRAS(max.). At the end of precharge, the precharged bank is still in the idle state and is ready to be activated again.



3 PrechargeAll command

(RAS#="L",CAS#="H",WE#="L",BS =Don t care,A10 ="H")

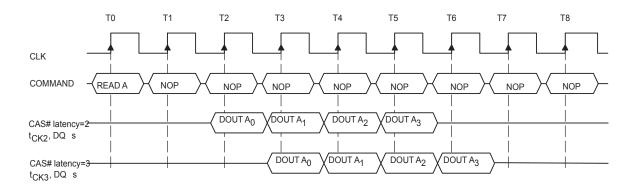
The Precharge All command precharges all the four banks simultaneously and can be issued even if all banks are not in the active state. All banks are then switched to the idle state.

4 Read command

(RAS#="H",CAS#="L",WE#="H",BS =Bank,A10 ="L",A0-A7 =Column Address)

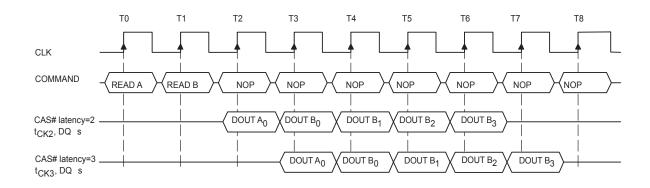
The Read command is used to read a burst of data on consecutive clock cycles from an active row in an active bank. The bank must be active for at least tRCD(min.) before the Read command is issued. During read bursts, the valid data-out element from the starting column address will be available following the CAS# latency after the issue of the Read command. Each subsequent data- out element will be valid by the next positive clock edge (refer to the following figure). The DQs go into high-impedance at the end of the burst unless other command is initiated. The burst length, burst sequence, and CAS# latency are determined by the mode register which is already programmed. A full-page burst will continue until terminated (at the end of the page it will wrap to column 0 and continue).





Burst Read Operation(Burst Length =4,CAS#Latency =2,3)

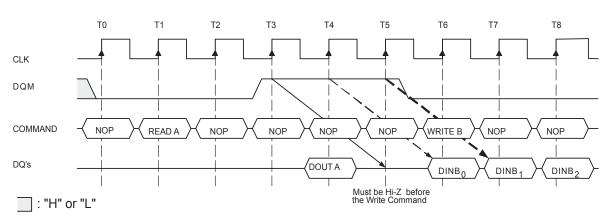
The read data appears on the DQs subject to the values on the DQM inputs two clocks earlier (i.e.DQM latency is two clocks for output buffers). A read burst without the auto precharge function may be interrupted by a subsequent Read or Write command to the same bank or the other active bank before the end of the burst length. It may be interrupted by a BankPrecharge/PrechargeAll command to the same bank too. The interrupt coming from the Read command can occur on any clock cycle following a previous Read command (refer to the following figure).



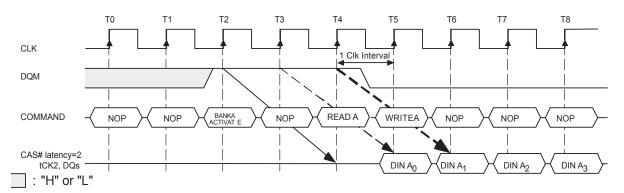
Read Interrupted by a Read (Burst Length =4,CAS#Latency =2,3)

The DQM inputs are used to avoid I/O contention on the DQ pins when the interrupt comes from a Write command. The DQMs must be asserted (HIGH)at least two clocks prior to the Write command to suppress data-out on the DQ pins. To guarantee the DQ pins against I/O contention, a single cycle with high-impedance on the DQ pins must occur between the last read data and the Write command (refer to the following three figures). If the data output of the burst read occurs at the second clock of the burst write, the DQMs must be asserted (HIGH)at least one clock prior to the Write command to avoid internal bus contention.

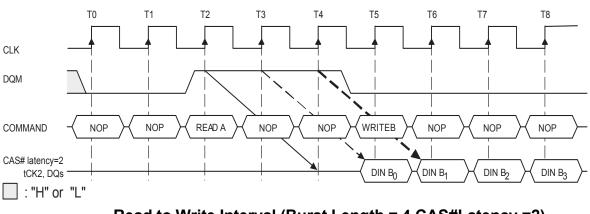






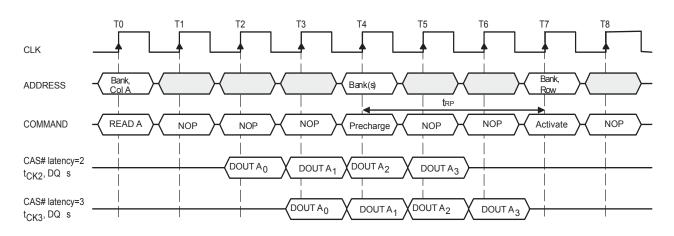






Read to Write Interval (Burst Length = 4,CAS#Latency =2)

A read burst without the auto precharge function may be interrupted by a BankPrecharge/ PrechargeAll command to the same bank. The following figure shows the optimum time that BankPrecharge/PrechargeAll command is issued in different CAS#latency.



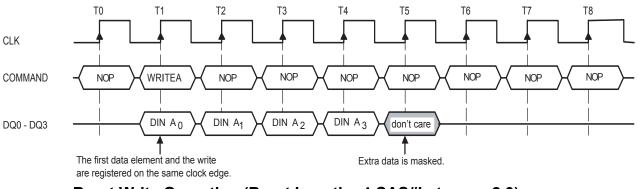
www.DataSheet4U

Read to Precharge (CAS#Latency =2,3)

5 Write command

(RAS#="H",CAS#="L",WE#="L",BS =Bank,A10 ="L",A0-A7 =Column Address)

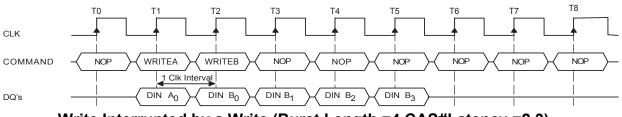
The Write command is used to write a burst of data on consecutive clock cycles from an active row in an active bank. The bank must be active for at least tRCD(min.) before the Write command is issued. During write bursts, the first valid data-in element will be registered coincident with the Write command. Subsequent data elements will be registered on each successive positive clock edge (refer to the following figure). The DQs remain with high-impedance at the end of the burst unless another command is initiated. The burst length and burst sequence are determined by the mode register, which is already programmed. A full-page burst will continue until terminated (at the end of the page it will wrap to column 0 and continue).



Burst Write Operation (Burst Length =4,CAS#Latency =2,3)

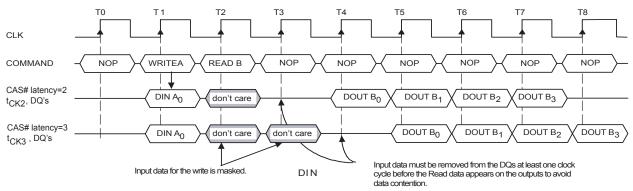
A write burst without the AutoPrecharge function may be interrupted by a subsequent Write, BankPrecharge/ PrechargeAll,or Read command before the end of the burst length. An interrupt coming from Write command can occur on any clock cycle following the previous Write command (refer to the following figure).





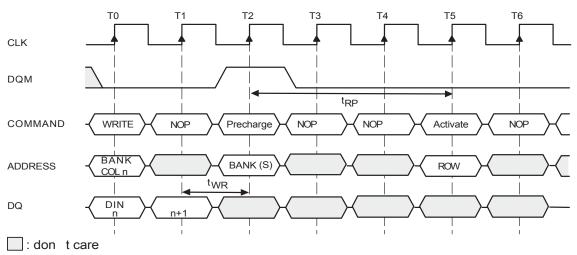
Write Interrupted by a Write (Burst Length =4,CAS#Latency =2,3)

The Read command that interrupts a write burst without auto precharge function should be issued one cycle after the clock edge in which the last data-in element is registered. In order to avoid data contention, input data must be removed from the DQs at least one clock cycle before the first read data appears on the outputs (refer to the following figure). Once the Read command is registered, the data inputs will be ignored and writes will not be executed.



Write Interrupted by a Read (Burst Length =4,CAS#Latency =2,3)

The BankPrecharge/PrechargeAll command that interrupts a write burst without the auto precharge function should be issued *m* cycles after the clock edge in which the last data-in element is registered, where *m* equals tWR/ tCK rounded up to the next whole number. In addition, the DQM signals must be used to mask input data, starting with the clock edge following the last data-in element and ending with the clock edge on which the BankPrecharge/ PrechargeAll command is entered (refer to the following figure).



Note: The DQMs can remain low in this example if the length of the write burst is 1 or 2.

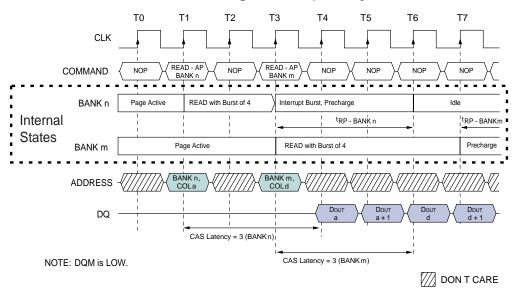
Write to Precharge

6 Concurrent Auto Precharge

An access command (READ or WRITE) to another bank while an access command with auto precharge enabled is executing is not allowed by SDRAMs, unless the SDRAM supports CONCURRENT AUTO PRECHARGE. ICSI SDRAMs support CONCURRENT AUTO PRECHARGE. Four cases where CONCURRENT AUTO PRECHARGE occurs are defined below.

READ with Auto Precharge

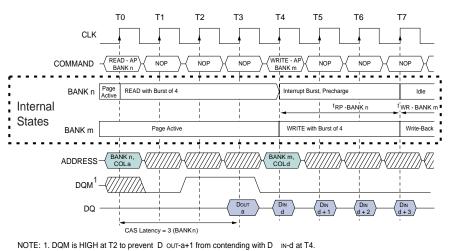
• Interrupted by a READ (with or without auto precharge): A READ to bank m will interrupt a READ on bank n, CAS latency later. The PRECHARGE to bank n will begin when the READ to bank m is regis-tered.



READ With Auto Precharge Interrupted by a READ

 Interrupted by a WRITE (with or without auto precharge): A WRITE to bank m will interrupt a READ on bank n when registered. DQM should be used two clocks prior to the WRITE command to prevent bus contention. The PRECHARGE to bank n will begin when the WRITE to bank m is registered.



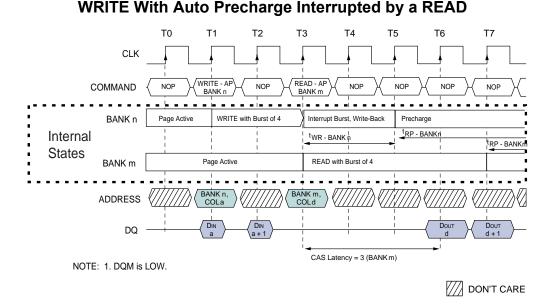


DON'T CARE

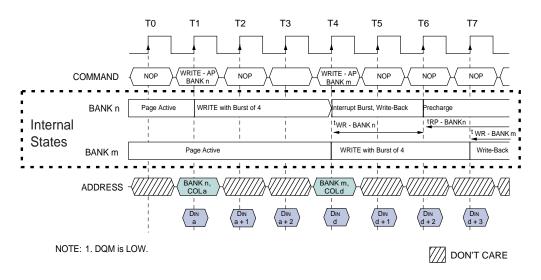


WRITE with Auto Precharge

 Interrupted by a READ (with or without auto precharge): A READ to bank m will interrupt a WRITE on bank n when registered, with the data-out ap- pearing CAS latency later. The PRECHARGE to bank n will begin after t WR is met, where t WR begins when the READ to bank m is registered. The last valid WRITE to bank n will be data-in registered one clock prior to the READ to bank m.



 Interrupted by a WRITE (with or without auto precharge): A WRITE to bank m will interrupt a WRITE on bank n when registered. The PRECHARGE to bank n will begin after t WR is met, where t WR begins when the WRITE to bank m is registered. The last valid data WRITE to bank n will be data registered one clock prior to a WRITE to bank m.



WRITE With Auto Precharge Interrupted by a WRITE

7 Mode Register Set command

(RAS#="L",CAS#="L",WE#="L",BS0,1 and A11-A0 =Register Data)

The mode register stores the data for controlling the various operating modes of SDRAM. The Mode Register Set command programs the values of CAS#latency,Addressing Mode and Burst Length in the Mode register to make SDRAM useful for a variety of different applications. The default values of the Mode Register after power-up are undefined; therefore this command must be issued at the power-up sequence. The state of pins BS0,1 and A11~A0 in the same cycle is the data written to the mode register. One clock cycle is required to complete the write in the mode register (refer to the following figure). The contents of the mode register can be changed using the same command and the clock cycle requirements during operation as long as all banks are in the idle state.

Т0 Т2 T3 Т6 Т8 Т9 T10 T1 Τ4 Τ5 Τ7 CLK tCK2 CKE Clock min CS# RAS# Т Т CAS# WE# Т Address Key ADDR. DQM trp Hi-Z DQ Mode Register Precharge All Any Set Command Command

Mode Register Set Cycle

The mode register is divided into various fields depending on functionality.

Address	BS0,1	A11/A10	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0
Function	RFU*		WBL	Test I	Vode	CA	S Later	су	BT	Bu	rst Len	gth

*Note:RFU (Reserved for future use)should stay 0 during MRS cycle.

[∦]D Burst Length Field (A2~A0)

This field specifies the data length of column access using the A2~A0 pins and selects the Burst Length to be 2, 4,8,or full page.

 A2	A1	A0	Burst Length
0	0	0	1
0	0	1	2
 0	1	0	4
0	1	1	8
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Full Page





Burst Type Field (A3)

The Burst Type can be one of two modes, Interleave Mode or Sequential Mode.

A3	Burst Type
0	Sequential
1	Interleave

-Addressing Sequence of Sequential Mode

An internal column address is performed by increasing the address from the column address which is input to the device. The internal column address is varied by the Burst Length as shown in the following table. When the value of column address, (n + m), in the table is larger than 255, only the least significant 8 bits are effective.

Data n	0	1	2	3	4	5	6	7	-	255	256	257	-
Column Address	n	n+1	n+2	n+3	n+4	n+5	n+6	n+7	-	n+255	n	n+1	-
	2 \	words:			[
Burst Length	4 ۱	words:											
	8 ۱	words:							L				
	Full	Full Page: Column address is repeated until terminated.											

Addressing Sequence of Interleave Mode

A column access is started in the input column address and is performed by inverting the address bits in the sequence shown in the following table.

Data n			Bur	st Length						
Data 0	A7	A6	A5	A4	A3	A2	A1	A0		
Data 1	A7	A6	A5	A4	A3	A2	A1	A0#	4 words	
Data 2	A7	A6	A5	A4	A3	A2	A1#	A0		
Data 3	A7	A6	A5	A4	A3	A2	A1#	A0#		8 words
Data 4	A7	A6	A5	A4	A3	A2#	A1	A0		
Data 5	A7	A6	A5	A4	A3	A2#	A1	A0#		
Data 6	A7	A6	A5	A4	A3	A2#	A1#	A0		
Data 7	A7	A6	A5	A4	A3	A2#	A1#	A0#		

• CAS#Latency Field (A6~A4)

This field specifies the number of clock cycles from the assertion of the Read command to the first read data. The minimum whole value of CAS#Latency depends on the frequency of CLK. The minimum whole value satisfying the following formula must be programmed into this field. t_{CAC}(min)<=CAS#Latency X t_{CK}

	A6	A5	A4	CAS#Latency
	0	0	0	Reserved
	0	0	1	Reserved
	0	1	0	2 clocks
	0	1	1	3 clocks
	1	Х	Х	Reserved
-				

Test Mode field (A8~A7)

These two bits are used to enter the test mode and must be programmed to "00" in normal operation.

A8	A7	Test Mode
0	0	normal mode
0	1	Vendor Use Only
1	Х	Vendor Use Only

• Write Burst Length (A9)

This bit is used to select the burst write length.

A9	Write Burst Length	
0	Burst	
1	Single Bit	

8 No-Operation command

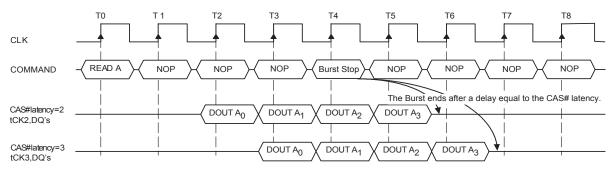
(RAS#="H",CAS#="H",WE#="H")

The No-Operation command is used to perform a NOP to the SDRAM which is selected (CS# is Low). This prevents unwanted commands from being registered during idle or wait states.

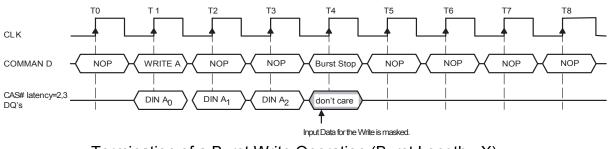
9 Burst Stop command

(RAS#="H",CAS#="H",WE#="L")

The Burst Stop command is used to terminate either fixed-length or full-page bursts. This command is only effective in a read/write burst without the auto precharge function. The terminated read burst ends after a delay equal to the CAS#latency (refer to the following figure). The termination of a write burst is shown in the following figure.



Termination of a Burst Read Operation (Burst Length > 4,CAS#Latency =2,3)



Termination of a Burst Write Operation (Burst Length =X)

IS42S32800B

10 Device Deselect command (CS#="H")

The Device Deselect command disables the command decoder so that the RAS#,CAS#,WE# and Address inputs are ignored,regardless of whether the CLK is enabled. This command is similar to the No Operation command.

- 11 AutoRefresh command
 - (RAS#="L",CAS#="L",WE#="H",CKE ="H")

The AutoRefresh command is used during normal operation of the SDRAM and is analogous to CAS#-before-RAS#(CBR)Refresh in conventional DRAMs. This command is non-persistent, so it must be issued each time a refresh is required. The addressing is generated by the internal refresh controller. This makes the address bits a "don 't care"during an AutoRefresh command. The internal refresh counter increments automatically on every auto refresh cycle to all of the rows. The refresh operation must be performed 4096 times within 64ms. The time required to complete the auto refresh operation is specified by tRC(min.). To provide the AutoRefresh command, all banks need to be in the idle state and the device must not be in power down mode (CKE is high in the previous cycle). This command must be followed by NOPs until the auto refresh operation is completed. The precharge time requirement, tRP(min), must be met before successive auto refresh operations are performed.

12 SelfRefresh Entry command

(RAS#="L",CAS#="L",WE#="H",CKE ="L")

The SelfRefresh is another refresh mode available in the SDRAM. It is the preferred refresh mode for data retention and low power operation. Once the SelfRefresh command is registered, all the inputs to the SDRAM become "don 't care" with the exception of CKE, which must remain LOW. The refresh addressing and timing is internally generated to reduce power consumption. The SDRAM may remain in SelfRefresh mode for an indefinite period. The SelfRefresh mode is exited by restarting the external clock and then asserting HIGH on CKE (SelfRefresh Exit command).

13 SelfRefresh Exit command

(CKE ="H",CS#="H"or CKE ="H",RAS#="H",CAS#="H",WE#="H")

This command is used to exit from the SelfRefresh mode.Once this command is registered, NOP or Device Deselect commands must be issued for tRC(min.)because time is required for the completion of any bank currently being internally refreshed.If auto refresh cycles in bursts are performed during normal operation, a burst of 4096 auto refresh cycles should be completed just prior to entering and just after exiting the SelfRefresh mode.

- 14 Clock Suspend Mode Entry /PowerDown Mode Entry command (CKE ="L") When the SDRAM is operating the burst cycle, the internal CLK is suspended (masked) from the subsequent cycle by issuing this command (asserting CKE "LOW"). The device operation is held intact while CLK is suspended. On the other hand, when all banks are in the idle state, this command performs entry into the PowerDown mode. All input and output buffers (except the CKE buffer) are turned off in the PowerDown mode. The device may not remain in the Clock Suspend or PowerDown state longer than the refresh period (64ms) since the command does not perform any refresh operations.
- 15 Clock Suspend Mode Exit /PowerDown Mode Exit command When the internal CLK has been suspended, the operation of the internal CLK is einitiated from the subsequent cycle by providing this command (asserting CKE "HIGH"). When the device is in the PowerDown mode, the device exits this mode and all disabled buffers are turned on to the active state.tPDE(min.) is required when the device exits from the PowerDown mode. Any subsequent commands can be issued after one clock cycle from the end of this command.
- 16 Data Write /Output Enable,Data Mask /Output Disable command (DQM ="L","H") During a write cycle,the DQM signal functions as a Data Mask and can control every word of the input data.During a read cycle,the DQM functions as the controller of output buffers.DQM is also used for device selection,byte selection and bus control in a memory system.

ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Parameters	Rating	Unit
Vdd	Supply Voltage (with respect to Vss)	–0.5 to +4.6	V
VDDQ	Supply Voltage for Output (with respec	ct to Vssq) -0.5 to +4.6	V
Vi	Input Voltage (with respect to Vss)	-0.5 to VDD+0.5	V
Vo	Output Voltage (with respect to Vsso	-1.0 to VDDQ+0.5	V
lo	Short circuit output current	50	mA
PD	Power Dissipation (T _A = 25 °C)	1	W
Торт	Operating Temperature Cor	n. 0 to +70	°C
	Ind.	-40 to +85	
Tstg	Storage Temperature	–65 to +150	°C

Notes:

1. Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

DC RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min.	Тур.	Max.	Unit
Vdd	Supply Voltage	3.0	3.3	3.6	V
Vddq	Supply Voltage for DQ	3.0	3.3	3.6	V
Vін	High Level Input Voltage (all Inputs)	2.0	_	Vdd + 1.2	V
Vı∟	Low Level Input Voltage (all Inputs)	-1.2	—	+0.8	V

Notes:

1. All voltages are referenced to Vss = 0V

2. VIH(max) for pulse width with \leq 3ns of duration

3. VIL(min) for pulse width with \leq 3ns of duration

CAPACITANCE CHARACTERISTICS

(At $T_A = 0 \sim 70^{\circ}$ C, $V_{DD} = V_{DDQ} = 3.3 \pm 0.3$ V, $V_{SS} = V_{SSQ} = 0$ V, unless otherwise noted)

Symbol	Parameter	Min.	Max.	Unit
CIN	Input Capacitance, address & control pin	1.5	3.0	pF
CCLK	Input Capacitance, CLK pin	1.5	3.0	pF
Cı/o	Data Input/Output Capacitance	3.0	5.5	pF

D.C. Electrical Characteristics (Recommended Operating Conditions)

Description/Test condition		Symbol	- 6/7 Max.	Unit	Note
$\begin{array}{c c} Operating Current & 1 bank \\ t_{RC} \geq t_{RC}(min), Outputs Open, Input \\ signal one transition per one cycle \end{array} \begin{array}{c} 1 bank \\ operation \end{array}$		Icc1	135/125		3
Precharge Standby Current in power do tcκ = 15ns, CKE ≤ V⊫(max)		ICC2P	3		3
Precharge Standby Current in power do tcκ = ∞, CKE ≤ Vι∟(max)		ICC2PS	2		
Precharge Standby Current in non-powe tcк = 15ns, CS#≥ Vн(min), CKE ≥ V _н Input signals are changed once during		Ісс2и	20		3
Precharge Standby Current in non-power down mode $t_{CK} = \infty$, CLK $\leq V_{IL}(max)$, CKE $\geq V_{IH}$		ICC2NS	9		
Active Standby Current in power down mode C KE \leq VIL(max), tck = 15ns		Іссзр	4	mA	3
Active Standby Current in power down mode CKE& CLK ≤ VIL(max), tcκ = ∞		Іссзря	3		3
Active Standby Current in non-power down mode $CKE \ge V_{H}(min), CS\# \ge V_{H}(min), tck = 15ns$		Іссзи	45		
Active Standby Current in non-power down mode CKE ≥ VIH(min), CLK ≤ VIL(max), tcκ = ∞		Іссзія	30		
Operating Current (Burst mode) tск =tск(min), Outputs Open, Multi-bank interleave		Icc4	180/150		3, 4
Refresh Current trc ≥ trc(min)		Icc5	300/270		3
Self Refresh Current C KE $\leq 0.2V$		Icc6	1 (L-Version) 3		

Parameter	Description	Min.	Max.	Unit	Note
lı.	Input Leakage Current ($0V \le VIN \le VDD$, All other pins not under test = $0V$)	- 1	+ 1	μA	
Iol	Output Leakage Current ($0V \le VOUT \le VDD$, DQ disable)	- 1.5	+ 1.5	μA	
Vон	LVTTL Output "H" Level Voltage (IOUT = -2mA)	2.4		V	
Vol	LVTTL Output "L" Level Voltage (Iout = 2mA)		0.4	V	

AC Electrical Characteristics (Recommended Operating Conditions)^{5,6,7,8}

			- 6/	17		
Symbol	A.C. Parameter		Min.	Max.	Unit	Note
t RC	Row cycle time (same bank)		60/70			9
t RRD	Row activate to row activate delay (different banks)	5				9
t RCD	RAS# to CAS# delay (same bank)		18/20			9
t RP	Precharge to refresh/row activate c (same bank)	command	18/20			9
tras	Row activate to precharge time (same bank)		42/45	120,000		9
tck2	Clock cycle time	CL* = 2	7.5/10			
tскз		CL* = 3	6/7		ns	
tac	Access time from CLK (positive edge)			5.5/5.5		9
tон	Data output hold time		2/2			9
tсн	Clock high time		2.5/2.5			10
tc∟	Clock low time		2.5/2.5			10
tıs	Data/Address/Control Input set-up	time	2.0/2.0			10
tıн	Data/Address/Control Input hold tir	ne	1			10
t∟z	Data output low impedance		1			9
tнz	Data output high impedance			5.4		8
twr	Write Recovery Time		2			
tccd	CAS# to CAS# Delay time		1		CLK	
tmrs	Mode Register Set cycle time		2			

* CL is CAS# Latency.

Note:

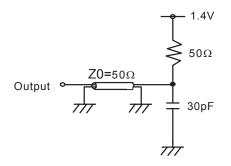
- 1. Stress greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device.
- 2. All voltages are referenced to VSS.
- 3. These parameters depend on the cycle rate and these values are measured by the cycle rate under the minimum value of tCK and tRC.Input signals are changed one time during tCK.
- 4. These parameters depend on the output loading. Specified values are obtained with the output open.
- 5. Power-up sequence is described in Note 11.

(Notes Continued)

6. A.C. Test Conditions

LVTTL Interface

Reference Level of Output Signals	1.4V /1.4V
Output Load	Reference to the Under Output Load
Input Signal Levels	2.4V /0.4V
Transition Time (Rise and Fall)of Input Signals	1ns
Reference Level of Input Signals	1.4V



LVTTL A.C. Test Load

- 7. Transition times are measured between VIH and VIL.Transition(rise and fall)of input signals are in a fixed slope (1 ns).
- 8. tHz defines the time in which the outputs achieve the open circuit condition and are not at reference levels.
- 9. If clock rising time is longer than 1 ns,(tR /2 -0.5)ns should be added to the parameter.
- 10. Assumed input rise and fall time tT (tR &tF)=1 ns

If tR or tF is longer than 1 ns,transient time compensation should be considered,i.e.,[(tr +tf)/2 -1]ns should be added to the parameter.

11. Power up Sequence

Power up must be performed in the following sequence.

1) Power must be applied to VDD and VDDQ(simultaneously)when all input signals are held "NOP"state and both CKE ="H"and DQM ="H."The CLK signals must be started at the same time.

2) After power-up,a pause of 200μ seconds minimum is required. Then, it is recommended that DQM is held "HIGH" (VDD levels) to ensure DQ output is in high impedance.

3) All banks must be precharged.

4) Mode Register Set command must be asserted to initialize the Mode register.

5) A minimum of 2 Auto-Refresh dummy cycles must be required to stabilize the internal circuitry of the device.



Timing Waveforms

Figure 1.AC Parameters for Write Timing (Burst Length=4,CAS#Latency=2)

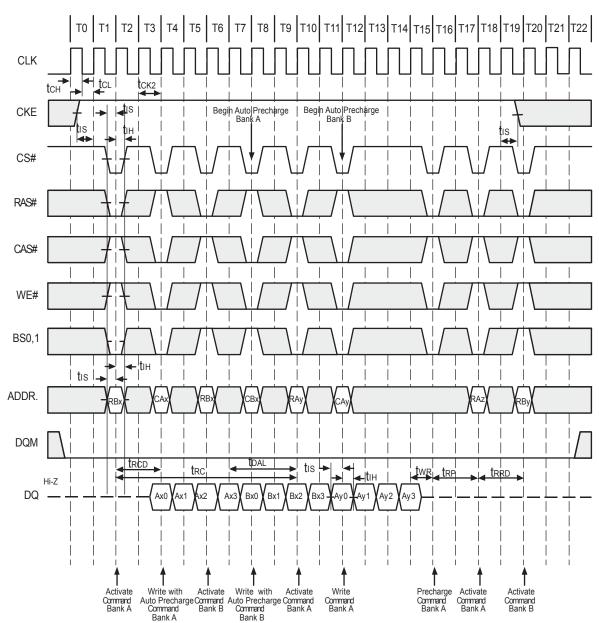
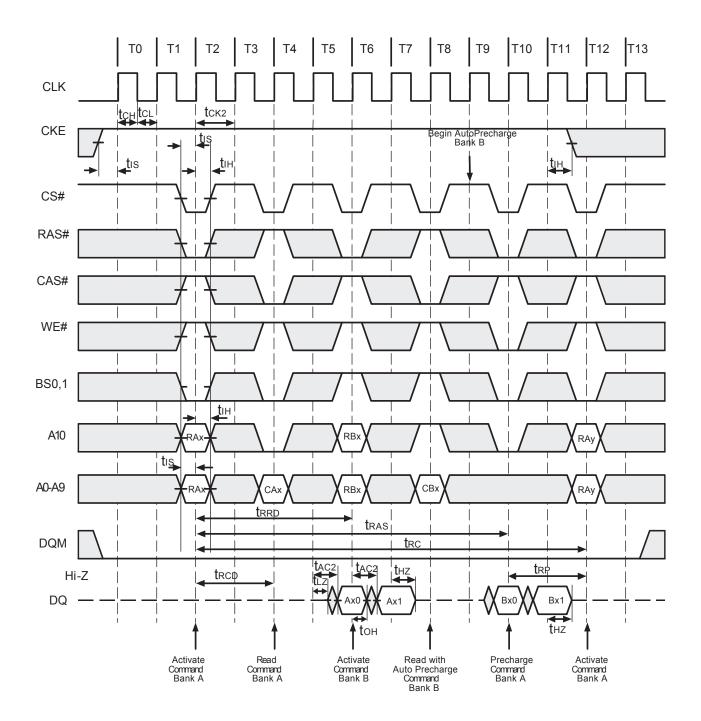




Figure 2.AC Parameters for Read Timing (Burst Length=2,CAS#Latency=2)



IS42S32800B



Figure 3.Auto Refresh (CBR)(Burst Length=4,CAS#Latency=2)

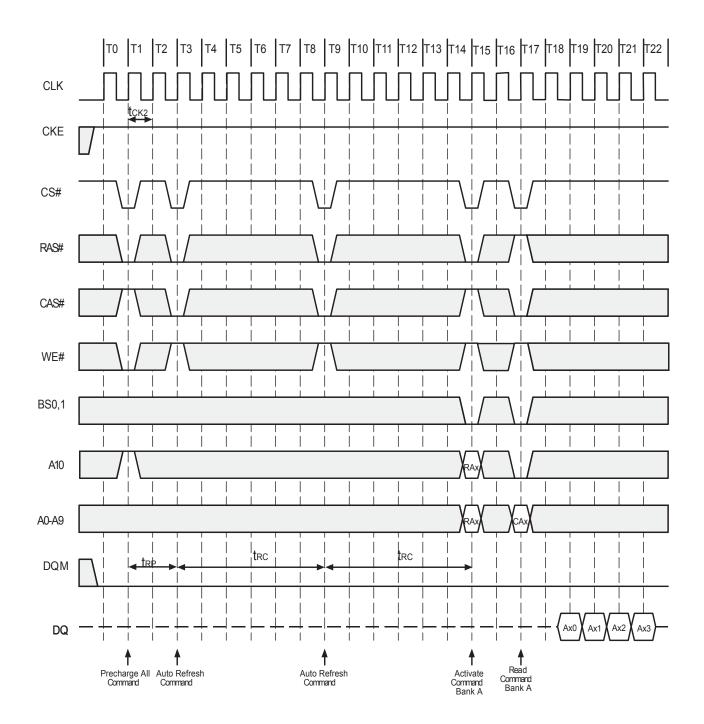




Figure 4.Power on Sequene and Auto Refresh (CBR)

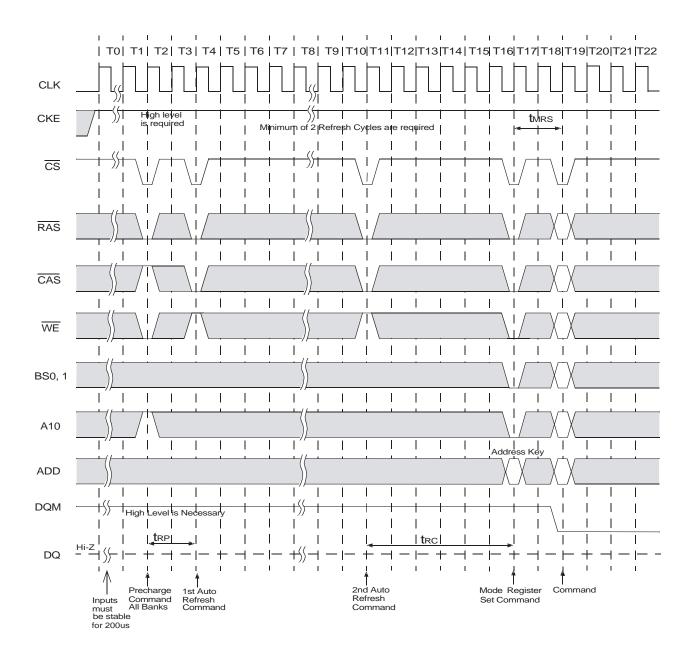
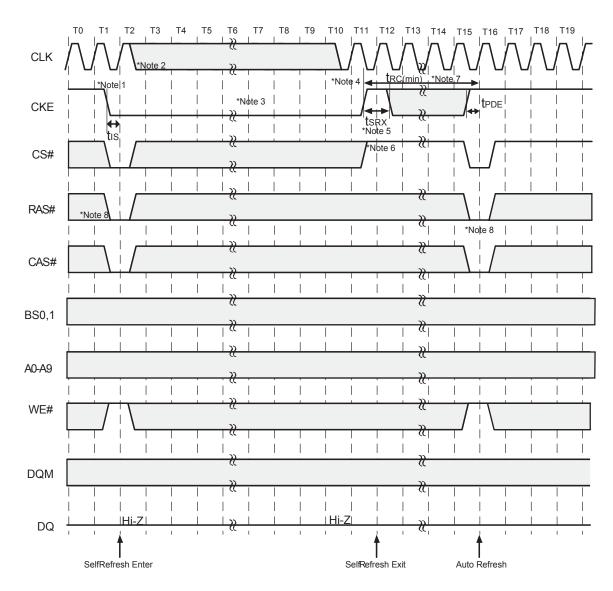




Figure 5.Self Refresh Entry & Exit Cycle



Note:To Enter SelfRefresh Mode

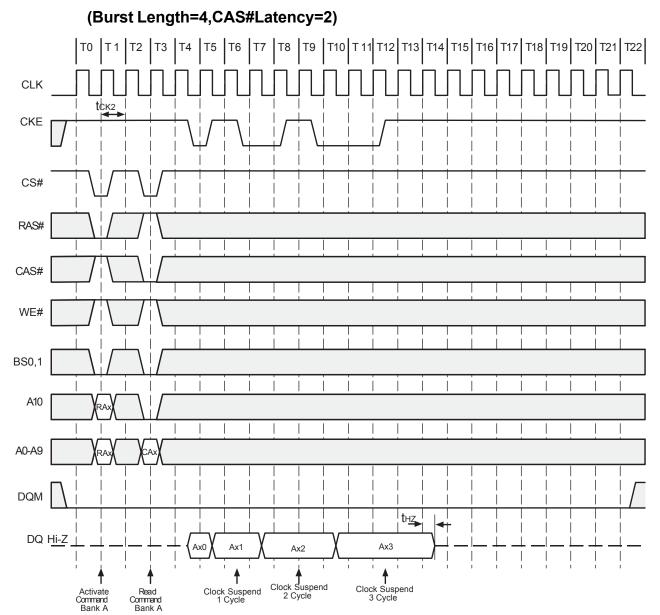
- 1. CS#,RAS#&CAS#with CKE should be low at the same clock cycle.
- 2. After 1 clock cycle, all the inputs including the system clock can be don 't care except for CKE.
- 3. The device remains in SelfRefresh mode as long as CKE stays "low".
- Once the device enters SelfRefresh mode, minimum tRAS is required before exit from SelfRefresh.

To Exit SelfRefresh Mode

- 1. System clock restart and be stable before returning CKE high.
- 2. Enable CKE and CKE should be set high for minimum time of tSRX.
- 3. CS#starts from high.
- 4. Minimum tRC is required after CKE going high to complete SelfRefresh exit.
- 5. 2048 cycles of burst AutoRefresh is required before SelfRefresh entry and after SelfRefresh exit if the system uses burst refresh.



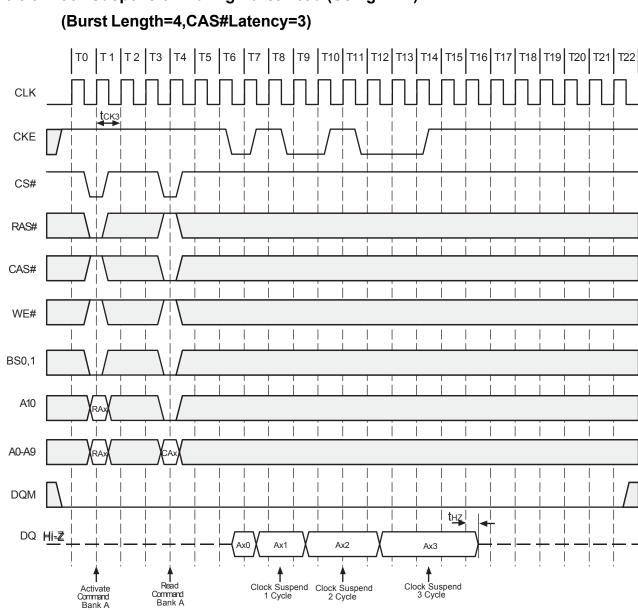




Note:CKE to CLK disable/enable =1 clock



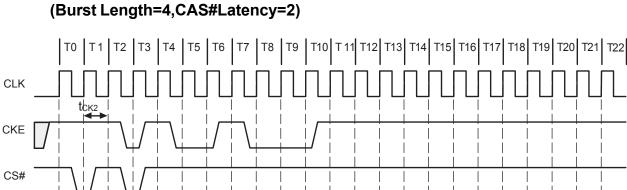
Figure 6.3. Clock Suspension During Burst Read (Using CKE)

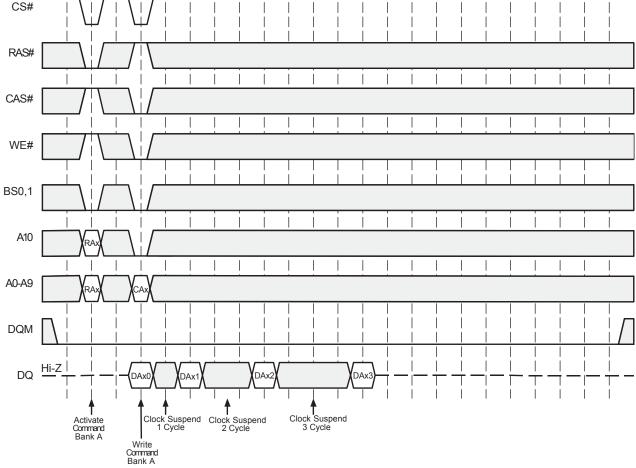


Note:CKE to CLK disable/enable =1 clock



Figure 7.2. Clock Suspension During Burst Write (Using CKE)

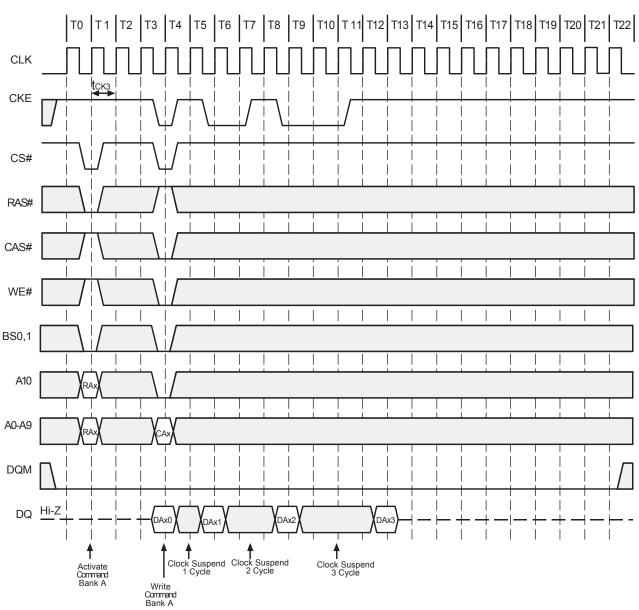




Note:CKE to CLK disable/enable =1 clock



Figure 7.3.Clock Suspension During Burst Write (Using CKE) (Burst Length=4,CAS#Latency=3)



Note:CKE to CLK disable/enable =1 clock



Figure 8.Power Down Mode and Clock Mask (Burst Lenght=4, CAS#Latency=2)

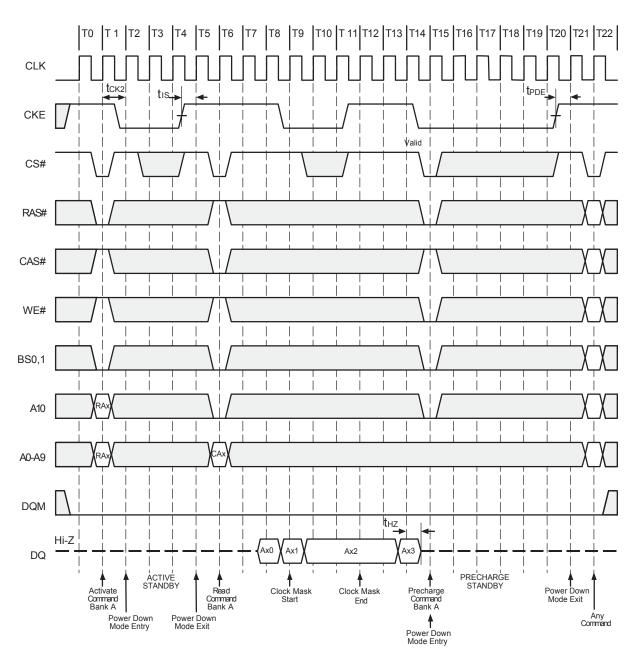




Figure 9.2.Random Column Read (Page within same Bank)



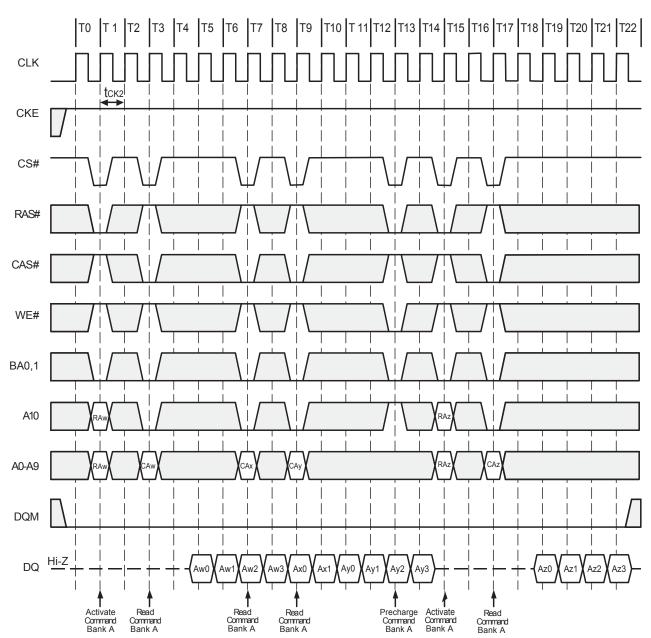




Figure 9.3.Random Column Read (Page within same Bank)

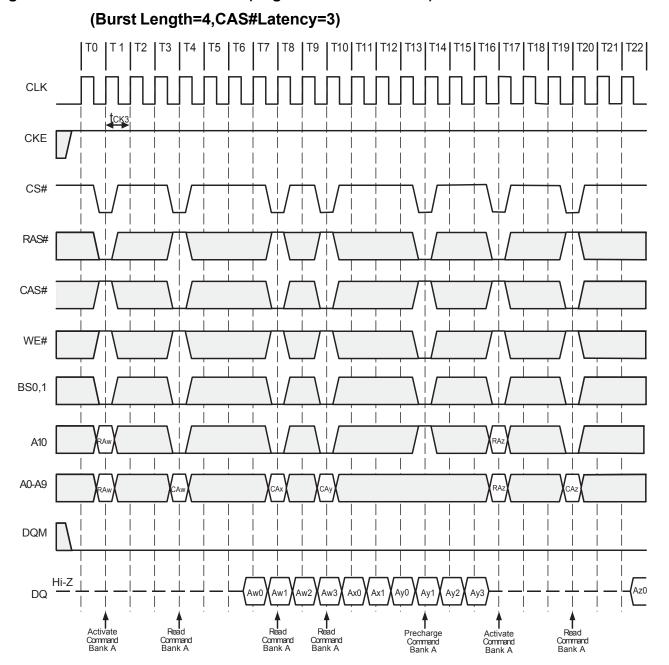




Figure 10.2.Random Column Write (Page within same Bank) (Burst Length=4,CAS#Latency=2) T9 T10 T 11 T12 T13 T14 T15 T16 T17 T18 T19 T20 T21 T22 T0 Τ1 T2 Т3 T4 T5 T6 T7 T8 CLK tck2 CKE CS# RAS# CAS# WE# BS0,1 RB RBz A10 A0-A9 СВу CB CBx RBz CBz 2R DQM <u>Hi-Z</u> DQ)Bx(٦R DBv ٦B DB۱ DB7 DBz DB۱ Write Command Bank A Write Command Bank B Write Command Bank B Activate Command Precharge Command Bank B Activate Command Bank B Write Command Bank B Bank A



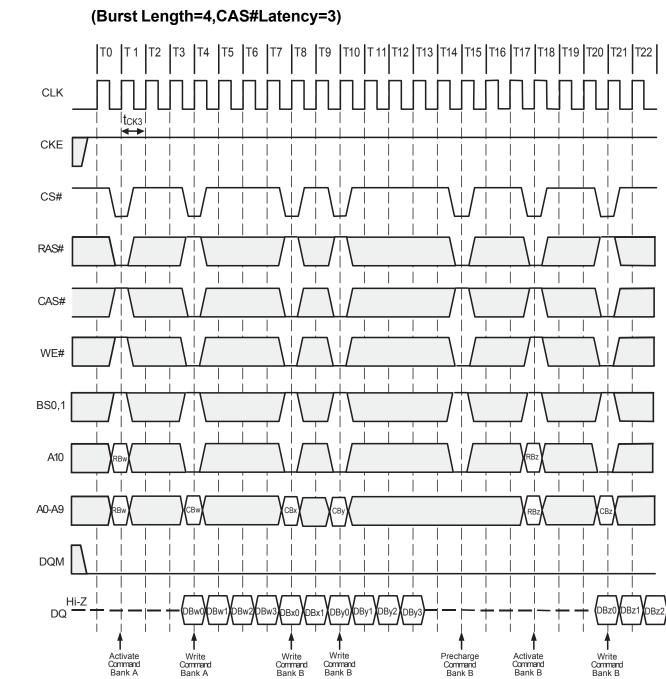


Figure 10.3.Random Column Write (Page within same Bank)

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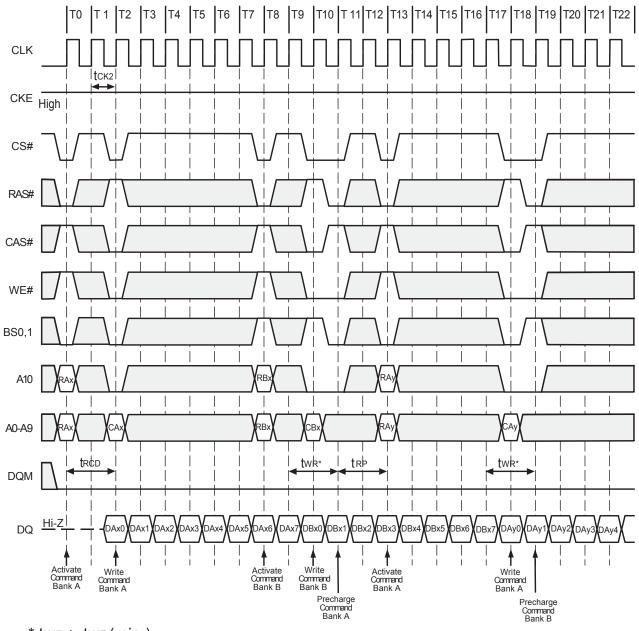


(Burst Length=8,CAS#Latency=3) |T10 |T 11|T12 |T13 |T14 |T15 |T16 |T17 |T18 |T19 |T20 |T21 |T22 | T0 Τ4 T5 T6 T8 T9 T 1 T2 Τ3 **T**7 CLK tok3 --CKE High CS# RAS# CAS# WE# BS0,1 RB) RB RA> A10 ٦A RBy A0-A9 RB) СВ> A: CB trcd |tAC3| 1t_{RP} DQM Hi-Z DQ By0 Bx0 Bx1 Bx2 Bx3 Bx4 Bx5 Bx7 Ax0 Ax1 Ax2 Ax5 Ax6 Ax7 Bx6 Ax3 Ax4 f f T Activate Command Bank B Activate Command Bank A Activate Command Bank B Read Command Bank B Precharge Command Bank A Read Read Command Bank A Precharge Command Bank B Command Bank B



Figure 12.2.Random Row Write (Interleaving Banks)

(Burst Length=8,CAS#Latency=2)



* twr > twr(min.)



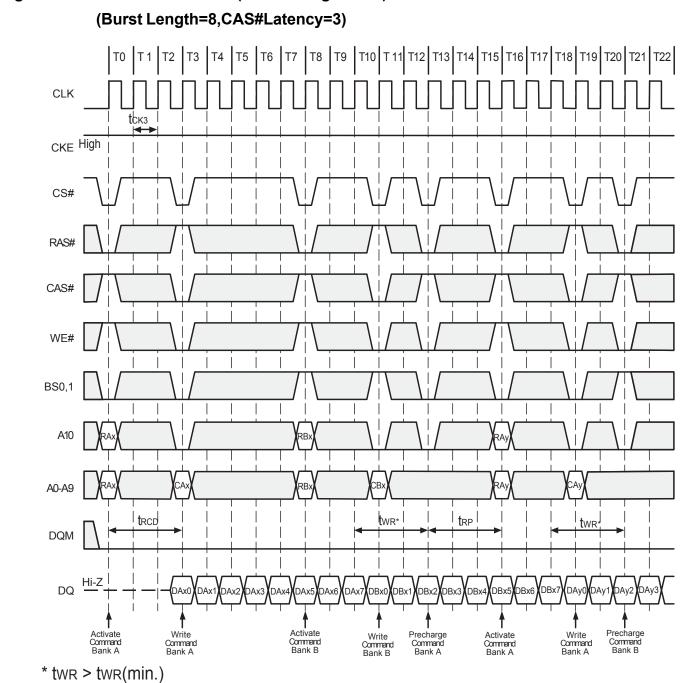


Figure 12.3.Random Row Write (Interleaving Banks)



Figure 13.2.Read and Write Cycle (Burst Length=4,CAS#Latency=2)

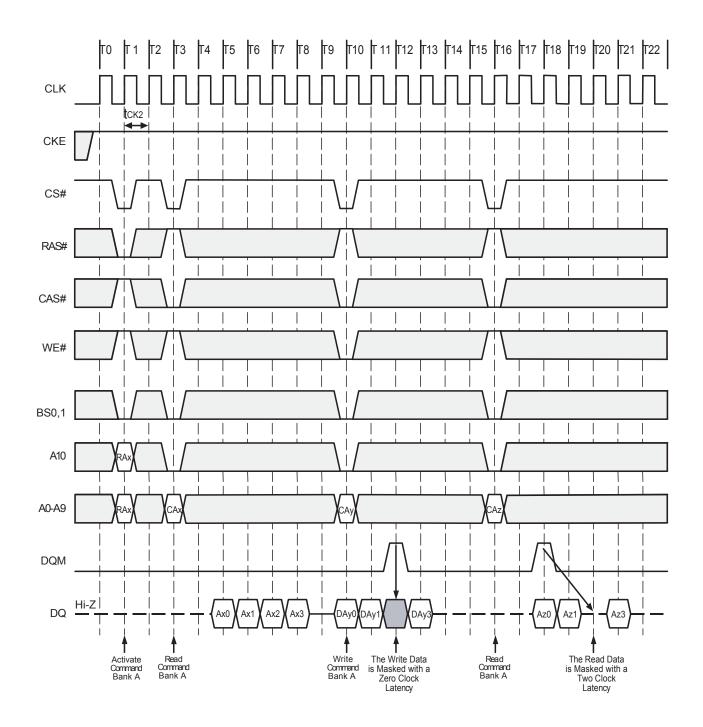




Figure 13.3.Read and Write Cycle (Burst Length=4,CAS#Latency=3)

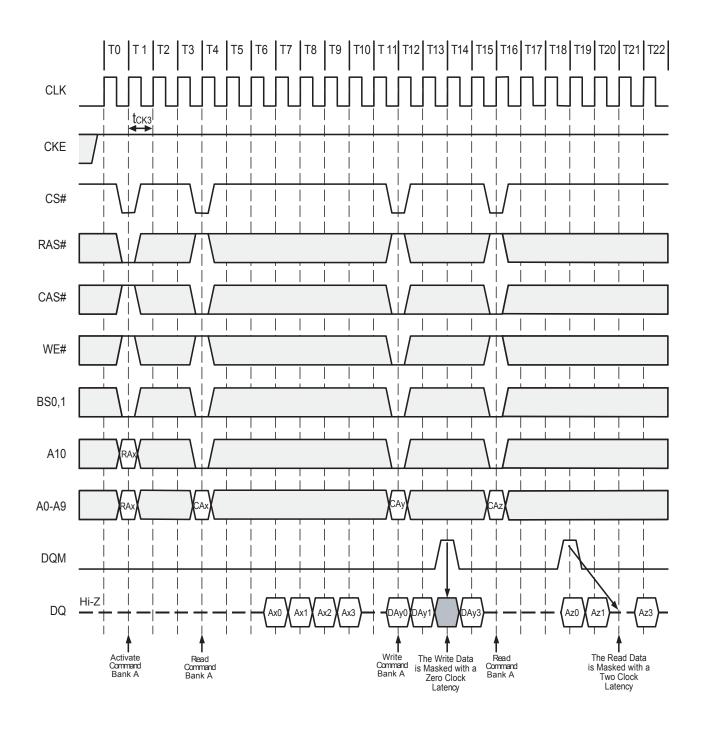
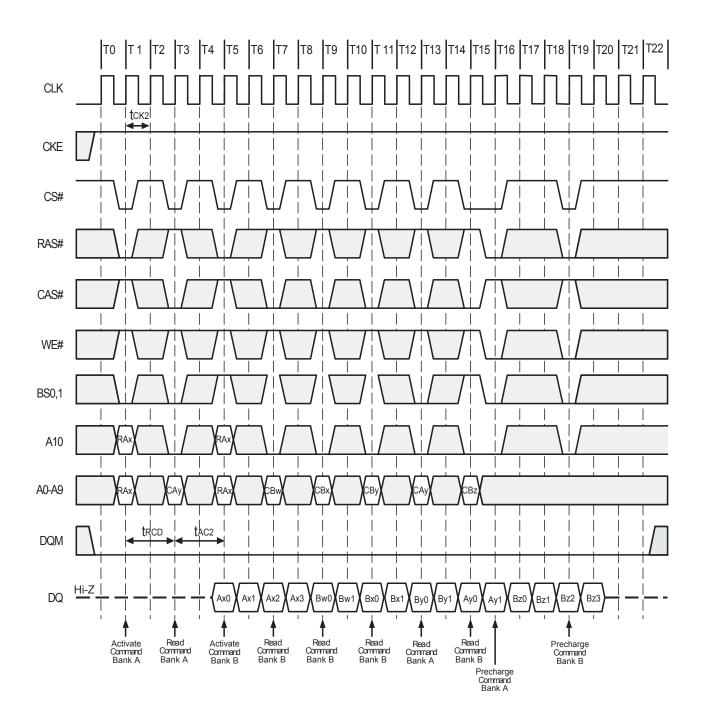




Figure 14.2.Interleaving Column Read Cycle (Burst Length=4,CAS#Latency=2)







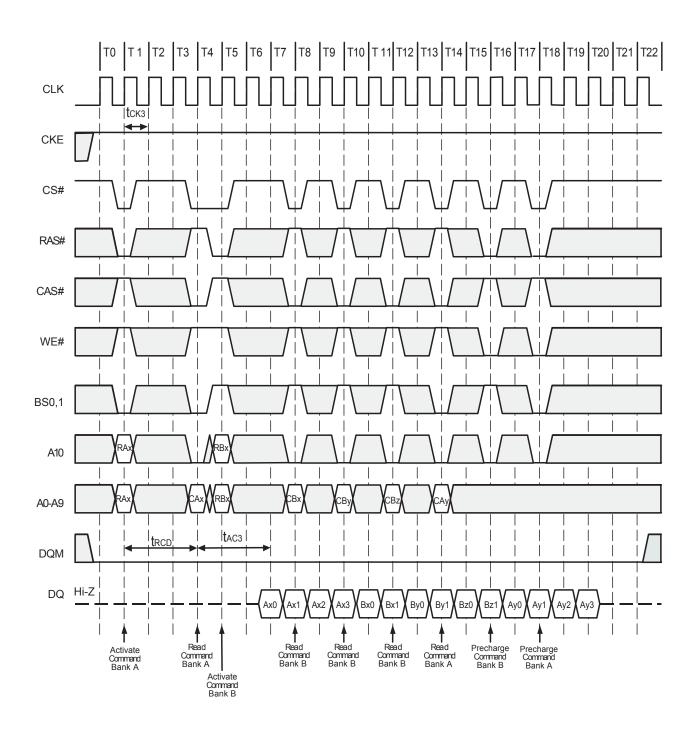




Figure 15.2.Interleaved Column Write Cycle (Burst Length=4,CAS#Latency=2)

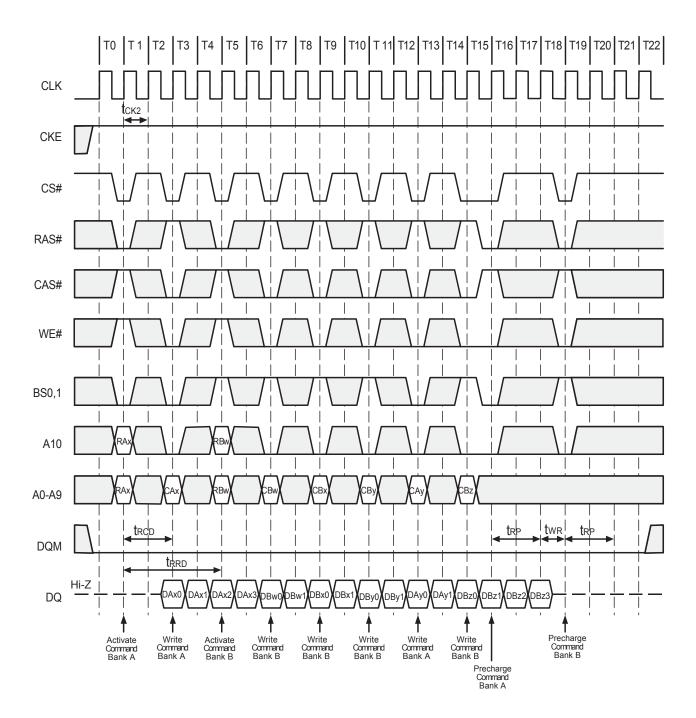




Figure 15.3.Interleaved Column Write Cycle (Burst Length=4,CAS#Latency=3)

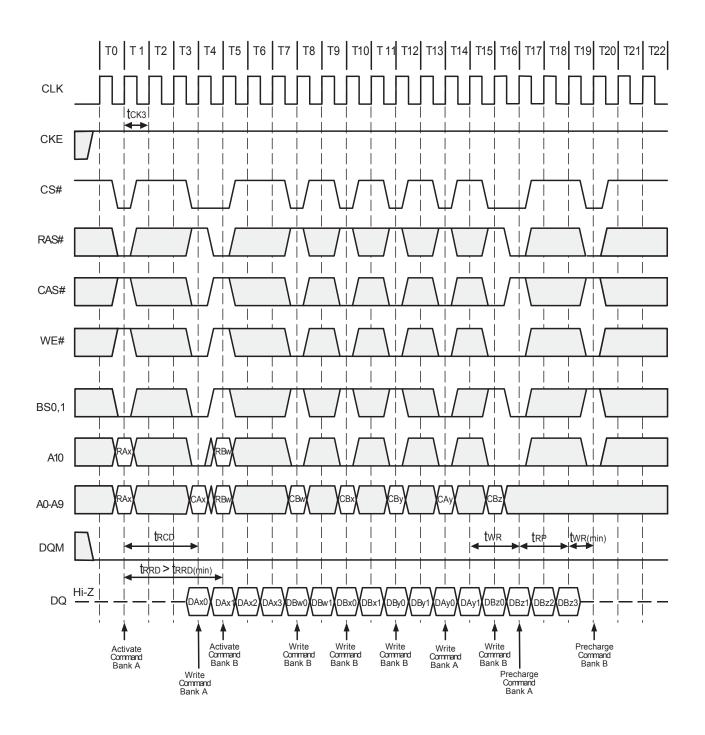
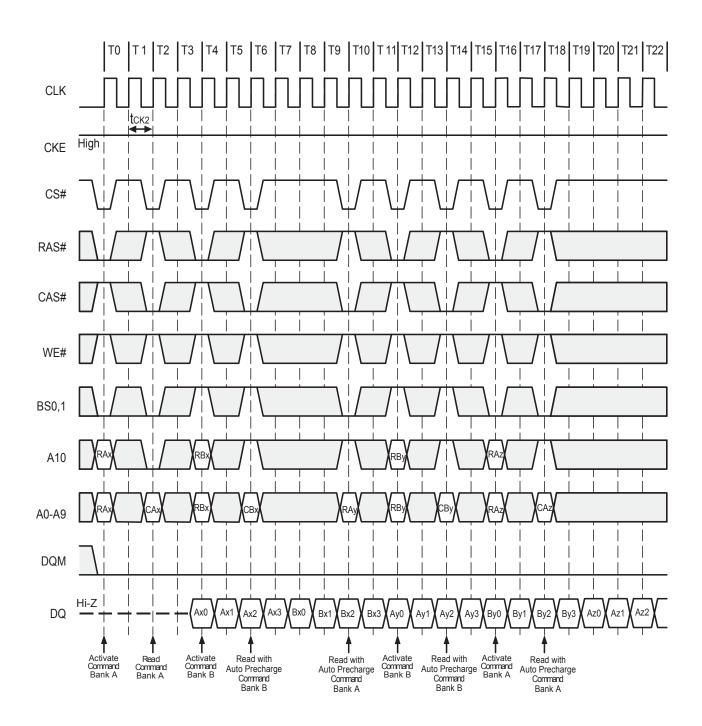




Figure 16.2.Auto Precharge after Read Burst (Burst Length=4,CAS#Latency=2)







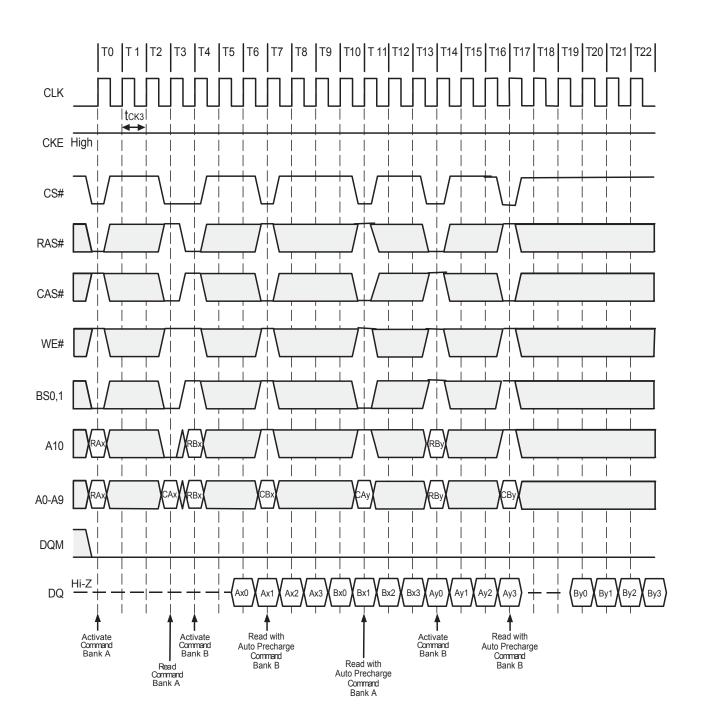




Figure 17.2.Auto Precharge after Write Burst (Burst Length=4,CAS#Latency=2)

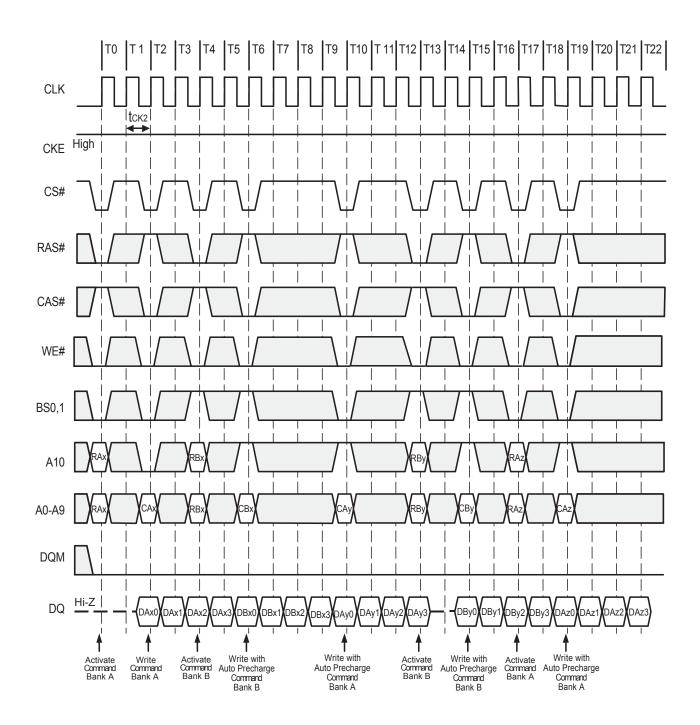




Figure 17.3.Auto Precharge after Write Burst (Burst Length=4,CAS#Latency=3)

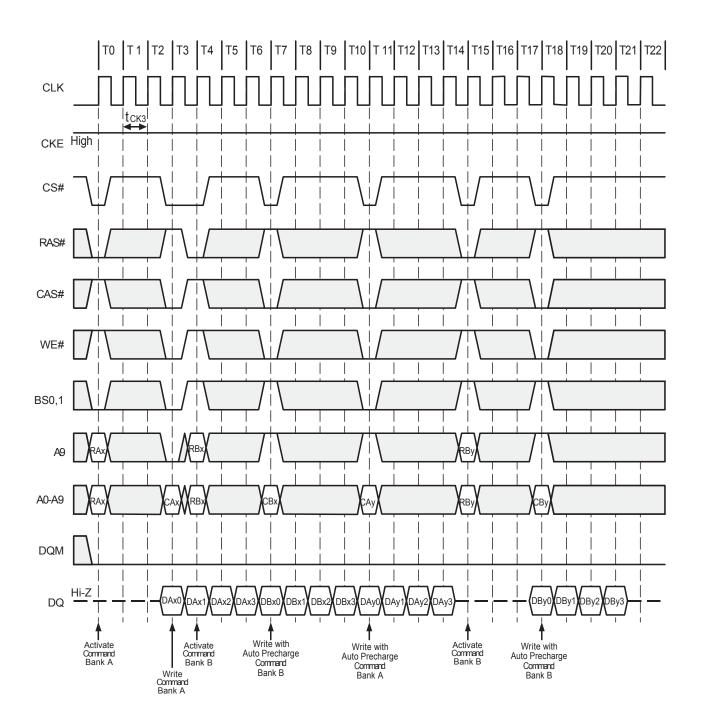




Figure 18.2.Full Page Read Cycle (Burst Length=Full Page,CAS#Latency=2)

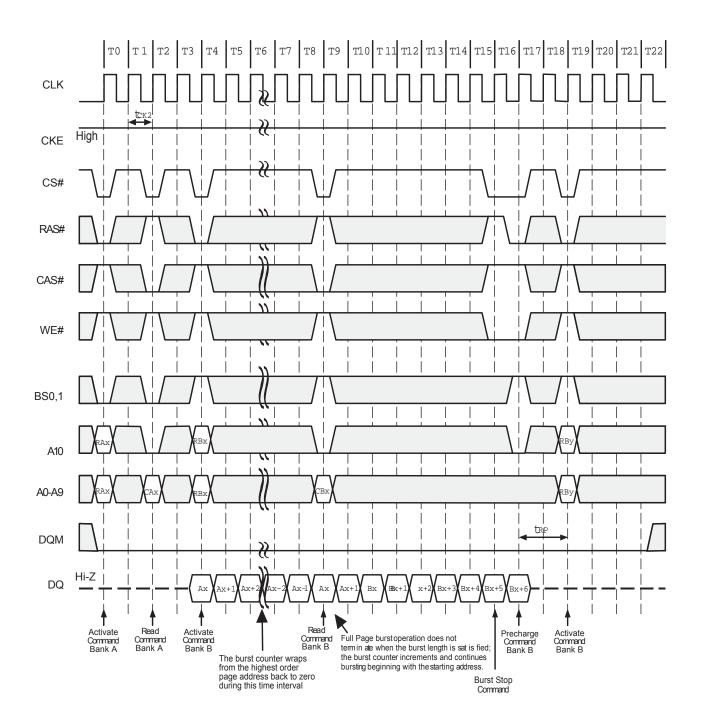




Figure 18.3.Full Page Read Cycle (Burst Length=Full Page,CAS#Latency=3)

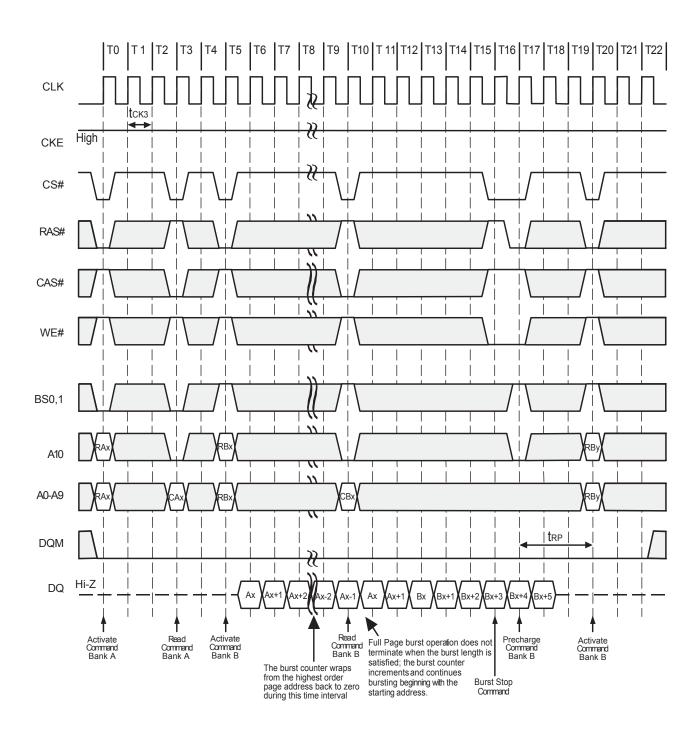




Figure 19.2.Full Page Write Cycle (Burst Length=Full Page,CAS#Latency=2)

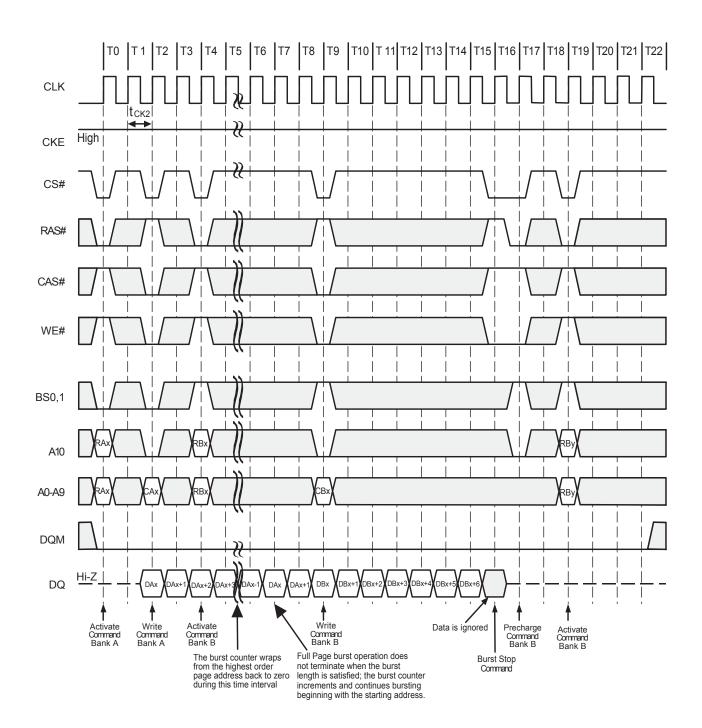




Figure 19.3.Full Page Write Cycle (Burst Length=Full Page,CAS#Latency=3)

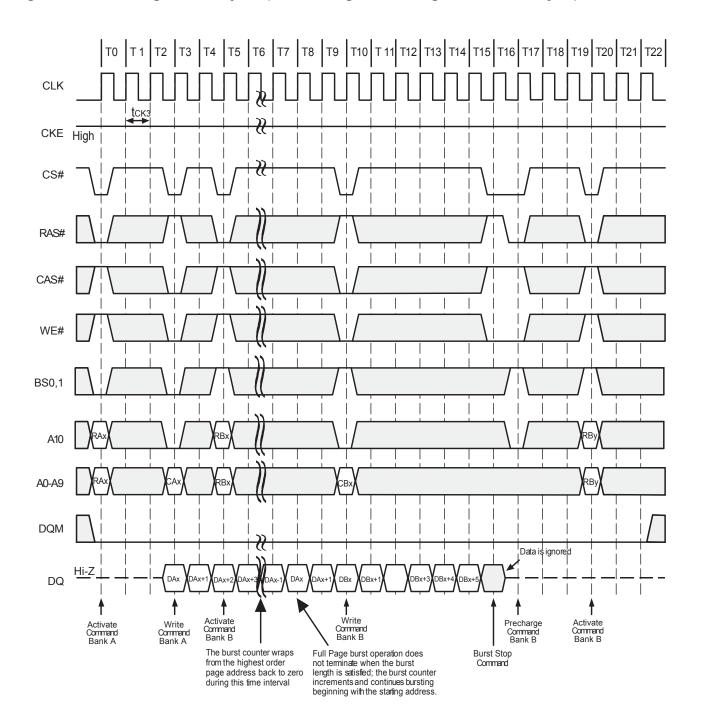




Figure 20.Byte Write Operation (Burst Length=4,CAS#Latency=2)

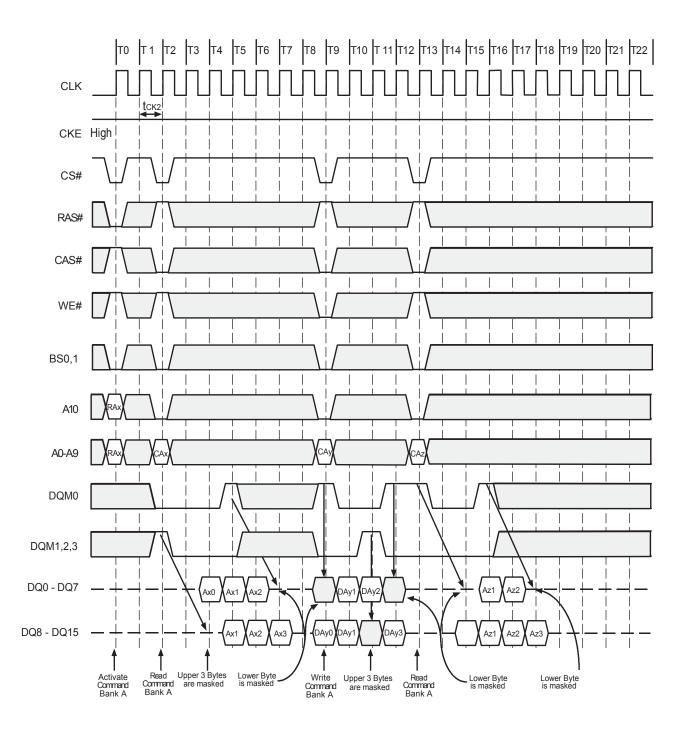




Figure 22.Full Page Random Column Read (Burst Length=Full Page,CAS#Latency=2)

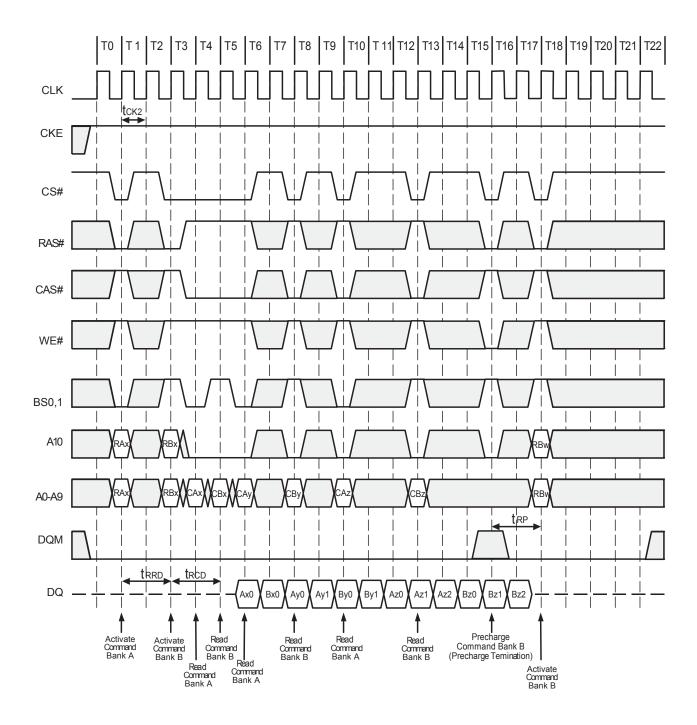
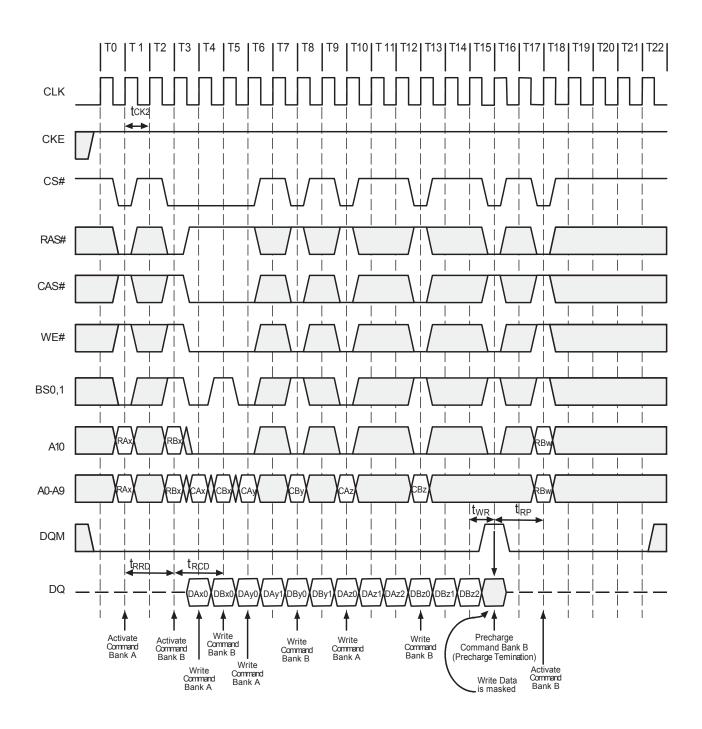




Figure 23.Full Page Random Column Write (Burst Length=Full Page,CAS#Latency=2)





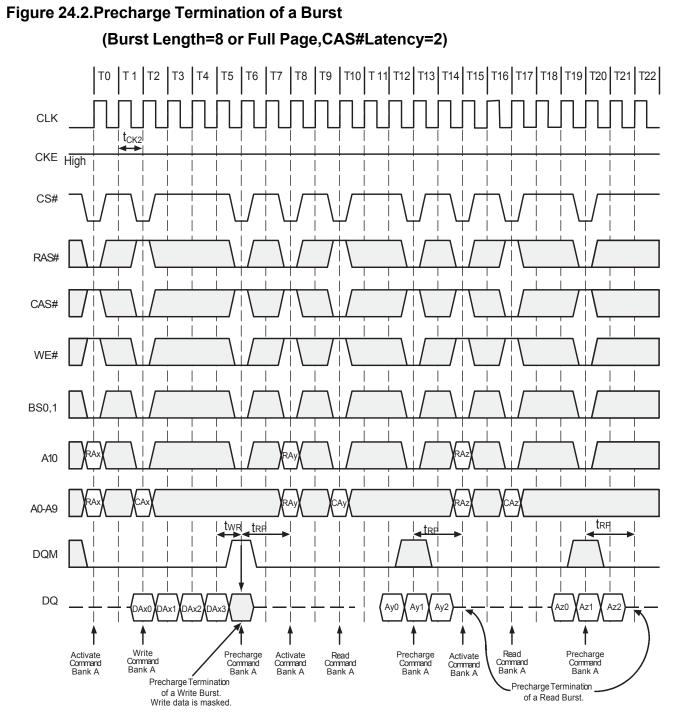
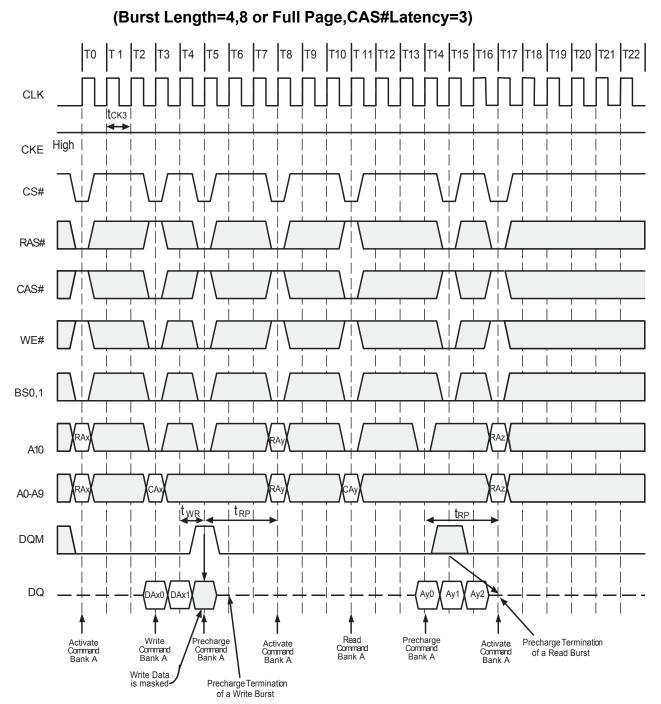




Figure 24.3. Precharge Termination of a Burst



ORDERING INFORMATION

Commercial Range: 0°C to +70°C

Frequency	Speed (ns)	Order Part No.	Package
166 MHz	6	IS42S32800B-6T	400 mil TSOP-II
166 MHz	6	IS42S32800B-6TL	400 mil TSOP-II, Lead-free
166 MHz	6	IS42S32800B-6B	8 x13mm BGA
166 MHz	6	IS42S32800B-6BL	8 x13mm BGA, Lead-free
143 MHz	7	IS42S32800B-7T	400 mil TSOP-II
143 MHz	7	IS42S32800B-7TL	400 mil TSOP-II, Lead-free
143 MHz	7	IS42S32800B-7B	8 x13mm BGA
143 MHz	7	IS42S32800B-7BL	8 x13mm BGA, Lead-free

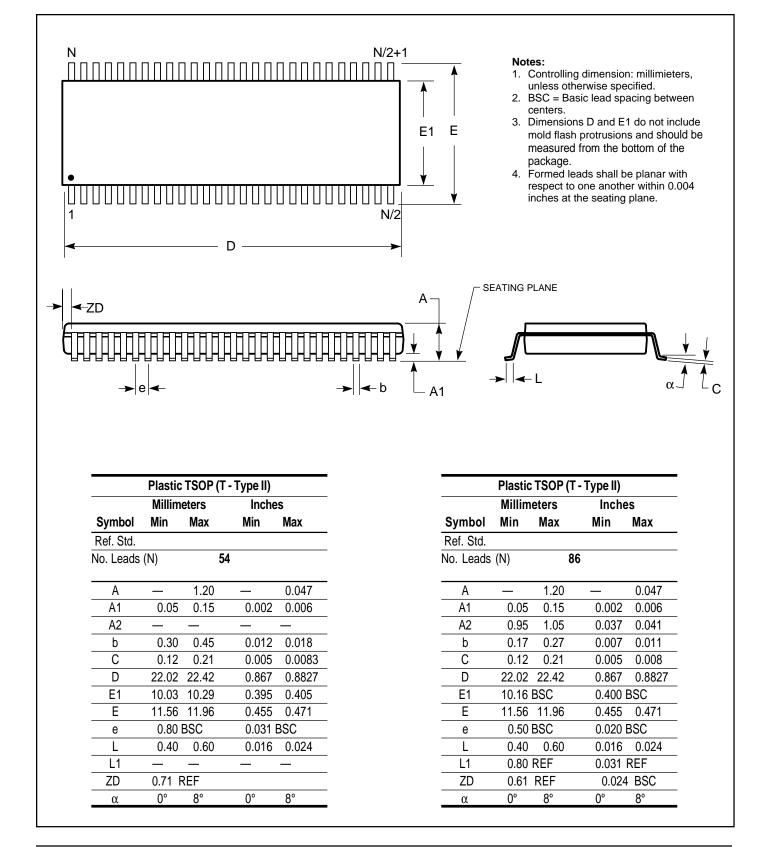
Industrial Range: -40°C to +85°C

Frequency	Speed (ns)	Order Part No.	Package
166 MHz	6	IS42S32800B-6TI	400 mil TSOP-II
166 MHz	6	IS42S32800B-6TLI	400 mil TSOP-II, Lead-free
166 MHz	6	IS42S32800B-6BI	8 x13mm BGA
166 MHz	6	IS42S32800B-6BLI	8 x13mm BGA, Lead-free
143 MHz	7	IS42S32800B-7TI	400 mil TSOP-II
143 MHz	7	IS42S32800B-7TLI	400 mil TSOP-II, Lead-free
143 MHz	7	IS42S32800B-7BI	8 x13mm BGA
143 MHz	7	IS42S32800B-7BLI	8 x13mm BGA, Lead-free

PACKAGING INFORMATION



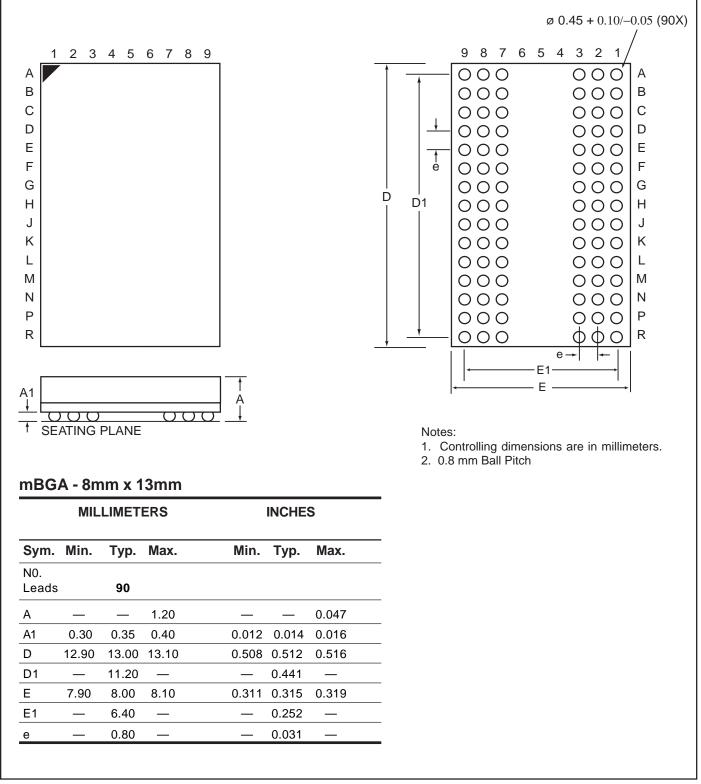
Plastic TSOP 54–Pin, 86-Pin Package Code: T (Type II)



PACKAGING INFORMATION



Mini Ball Grid Array Package Code: B (90-Ball)



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